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What is "Embedded - Microcontrollers"?

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Applications of "<u>Embedded - Microcontrollers</u>"

Product Status	Obsolete
Core Processor	80C51
Core Size	8-Bit
Speed	60/30MHz
Connectivity	UART/USART
Peripherals	POR
Number of I/O	32
Program Memory Size	-
Program Memory Type	ROMIess
EEPROM Size	-
RAM Size	128 x 8
Voltage - Supply (Vcc/Vdd)	4.5V ~ 5.5V
Data Converters	-
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-QFP
Supplier Device Package	44-PQFP
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/ts80c31x2-vic



## 4. SFR Mapping

The Special Function Registers (SFRs) of the TS80C31X2 fall into the following categories:

• C51 core registers: ACC, B, DPH, DPL, PSW, SP, AUXR1

• I/O port registers: P0, P1, P2, P3

• Timer registers: TCON, TH0, TH1, TMOD, TL0, TL1

• Serial I/O port registers: SADDR, SADEN, SBUF, SCON

Power and clock control registers: PCON

• Interrupt system registers: IE, IP, IPH

• Others: CKCON

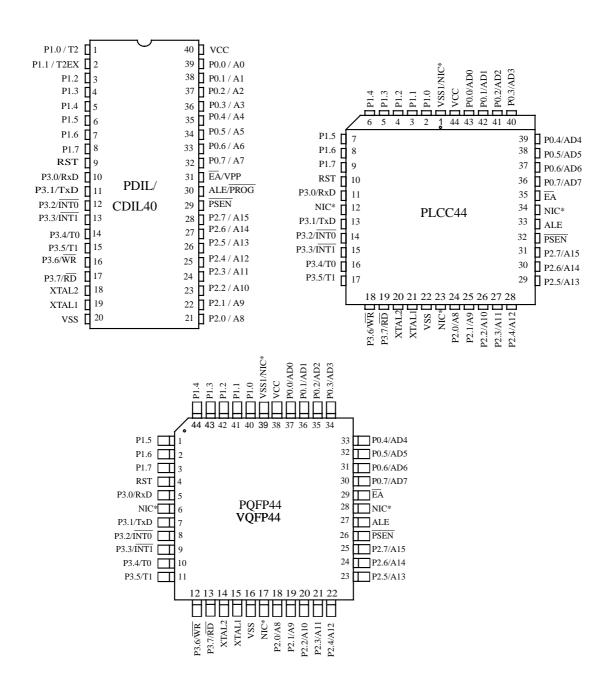
Table 1. All SFRs with their address and their reset value

	Bit address- able			Non	Bit address	able			
	0/8	1/9	2/A	3/B	4/C	5/D	6/E	7/F	
F8h									FFh
F0h	B 0000 0000								F7h
E8h									EFh
E0h	ACC 0000 0000								E7h
D8h									DFh
D0h	PSW 0000 0000								D7h
C8h									CFh
C0h									C7h
B8h	IP XXX0 0000	SADEN 0000 0000							BFh
B0h	P3 1111 1111							IPH XXX0 0000	B7h
A8h	IE 0XX0 0000	SADDR 0000 0000							AFh
A0h	P2 1111 1111		AUXR1 XXXX XXX0						A7h
98h	SCON 0000 0000	SBUF XXXX XXXX							9Fh
90h	P1 1111 1111								97h
88h	TCON 0000 0000	TMOD 0000 0000	TL0 0000 0000	TL1 0000 0000	TH0 0000 0000	TH1 0000 0000		CKCON XXXX XXX0	8Fh
80h	P0 1111 1111	SP 0000 0111	DPL 0000 0000	DPH 0000 0000				PCON 00X1 0000	87h
	0/8	1/9	2/A	3/B	4/C	5/D	6/E	7/F	

reserved



# 5. Pin Configuration



\*NIC: No Internal Connection

# **TS80C31X2**



## 6. TS80C31X2 Enhanced Features

In comparison to the original 80C31, the TS80C31X2 implements some new features, which are:

- The X2 option.
- The Dual Data Pointer.
- The 4 level interrupt priority system.
- · The power-off flag.
- The ONCE mode.
- Enhanced UART

#### 6.1 X2 Feature

The TS80C31X2 core needs only 6 clock periods per machine cycle. This feature called "X2" provides the following advantages:

- Divide frequency crystals by 2 (cheaper crystals) while keeping same CPU power.
- Save power consumption while keeping same CPU power (oscillator power saving).
- Save power consumption by dividing dynamically operating frequency by 2 in operating and idle modes.
- Increase CPU power by 2 while keeping same crystal frequency.

In order to keep the original C51 compatibility, a divider by 2 is inserted between the XTAL1 signal and the main clock input of the core (phase generator). This divider may be disabled by software.

#### 6.1.1 Description

The clock for the whole circuit and peripheral is first divided by two before being used by the CPU core and peripherals. This allows any cyclic ratio to be accepted on XTAL1 input. In X2 mode, as this divider is bypassed, the signals on XTAL1 must have a cyclic ratio between 40 to 60%. Figure 1. shows the clock generation block diagram. X2 bit is validated on XTAL1÷2 rising edge to avoid glitches when switching from X2 to STD mode. Figure 2. shows the mode switching waveforms.

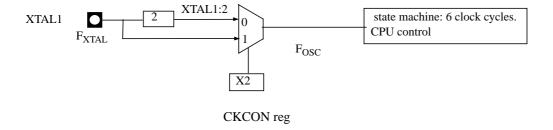


Figure 1. Clock Generation Diagram



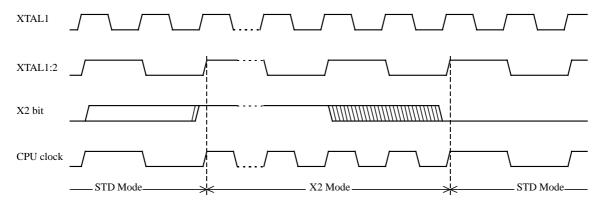


Figure 2. Mode Switching Waveforms

The X2 bit in the CKCON register (See Table 3.) allows to switch from 12 clock cycles per instruction to 6 clock cycles and vice versa. At reset, the standard speed is activated (STD mode). Setting this bit activates the X2 feature (X2 mode).

#### **CAUTION**

In order to prevent any incorrect operation while operating in X2 mode, user must be aware that all peripherals using clock frequency as time reference (UART, timers) will have their time reference divided by two. For example a free running timer generating an interrupt every 20 ms will then generate an interrupt every 10 ms. UART with 4800 baud rate will have 9600 baud rate.



## 6.2 Dual Data Pointer Register Ddptr

The additional data pointer can be used to speed up code execution and reduce code size in a number of ways.

The dual DPTR structure is a way by which the chip will specify the address of an external data memory location. There are two 16-bit DPTR registers that address the external memory, and a single bit called DPS = AUXR1/bit0 (See Table 5.) that allows the program code to switch between them (Refer to Figure 3).

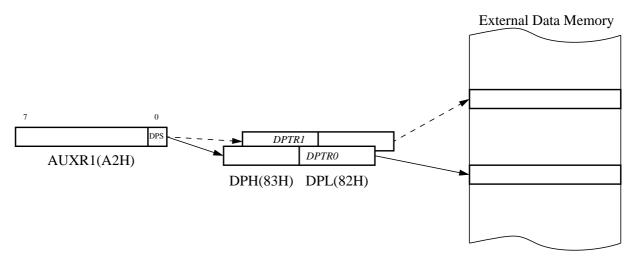


Figure 3. Use of Dual Pointer



Table 4. AUXR1: Auxiliary Register 1

7	6	5	4	3	2	1	0
-	-	-	-	-	-	-	DPS

Bit Number	Bit Mnemonic	Description
7	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
6	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
5	-	Reserved The value read from this bit is indeterminate. Do not set this bit.
4	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
3	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
2	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
1	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
0	DPS	Data Pointer Selection Clear to select DPTR0. Set to select DPTR1.

Reset Value = XXXX XXX0

Not bit addressable

## **Application**

Software can take advantage of the additional data pointers to both increase speed and reduce code size, for example, block operations (copy, compare, search ...) are well served by using one data pointer as a 'source' pointer and the other one as a "destination" pointer.

# **TS80C31X2**



#### 6.3 TS80C31X2 Serial I/O Port

The serial I/O port in the TS80C31X2 is compatible with the serial I/O port in the 80C31.

It provides both synchronous and asynchronous communication modes. It operates as an Universal Asynchronous Receiver and Transmitter (UART) in three full-duplex modes (Modes 1, 2 and 3). Asynchronous transmission and reception can occur simultaneously and at different baud rates

Serial I/O port includes the following enhancements:

- Framing error detection
- Automatic address recognition

#### **6.3.1 Framing Error Detection**

Framing bit error detection is provided for the three asynchronous modes (modes 1, 2 and 3). To enable the framing bit error detection feature, set SMOD0 bit in PCON register (See Figure 4).

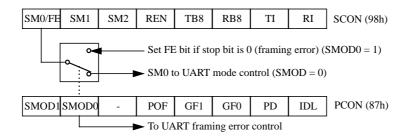


Figure 4. Framing Error Block Diagram

When this feature is enabled, the receiver checks each incoming data frame for a valid stop bit. An invalid stop bit may result from noise on the serial lines or from simultaneous transmission by two CPUs. If a valid stop bit is not found, the Framing Error bit (FE) in SCON register (See Table 5.) bit is set.



#### 6.3.5 Reset Addresses

On reset, the SADDR and SADEN registers are initialized to 00h, i.e. the given and broadcast addresses are XXXX XXXXb (all don't-care bits). This ensures that the serial port will reply to any address, and so, that it is backwards compatible with the 80C51 microcontrollers that do not support automatic address recognition.

#### SADEN - Slave Address Mask Register (B9h)

7	6	5	4	3	2	1	0

 $Reset\ Value=0000\ 0000b$ 

Not bit addressable

#### SADDR - Slave Address Register (A9h)

7	6	5	4	3	2	1	0

Reset Value = 0000 0000b

Not bit addressable



# Table 5. SCON Register

## SCON - Serial Control Register (98h)

7	6	5	4	3	2	1	0
FE/SM0	SM1	SM2	REN	TB8	RB8	TI	RI

Bit Number	Bit Mnemonic	Description	
7	FE	Framing Error bit (SMOD0=1)  Clear to reset the error state, not cleared by a valid stop bit.  Set by hardware when an invalid stop bit is detected.  SMOD0 must be set to enable access to the FE bit	
	SM0	Serial port Mode bit 0 Refer to SM1 for serial port mode selection. SMOD0 must be cleared to enable access to the SM0 bit	
		Serial port Mode bit 1 SM0 SM1 Mode Description Baud Rate	
6	SM1	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	ode)
5	SM2	Serial port Mode 2 bit / Multiprocessor Communication Enable bit Clear to disable multiprocessor communication feature. Set to enable multiprocessor communication feature in mode 2 and 3, and eventually mode 1. This bit shows be cleared in mode 0.	uld
4	REN	Reception Enable bit Clear to disable serial reception. Set to enable serial reception.	
3	ТВ8	Transmitter Bit 8 / Ninth bit to transmit in modes 2 and 3.  Clear to transmit a logic 0 in the 9th bit.  Set to transmit a logic 1 in the 9th bit.	
2	RB8	Receiver Bit 8 / Ninth bit received in modes 2 and 3  Cleared by hardware if 9th bit received is a logic 0.  Set by hardware if 9th bit received is a logic 1.  In mode 1, if SM2 = 0, RB8 is the received stop bit. In mode 0 RB8 is not used.	
1	TI	Transmit Interrupt flag Clear to acknowledge interrupt. Set by hardware at the end of the 8th bit time in mode 0 or at the beginning of the stop bit in the other modes.	
0	RI	Receive Interrupt flag  Clear to acknowledge interrupt.  Set by hardware at the end of the 8th bit time in mode 0, see Figure 5. and Figure 6. in the other modes.	

Reset Value = 0000 0000b

Bit addressable

# **TS80C31X2**



#### 6.5 Idle mode

An instruction that sets PCON.0 causes that to be the last instruction executed before going into the Idle mode. In the Idle mode, the internal clock signal is gated off to the CPU, but not to the interrupt, Timer, and Serial Port functions. The CPU status is preserved in its entirely: the Stack Pointer, Program Counter, Program Status Word, Accumulator and all other registers maintain their data during Idle. The port pins hold the logical states they had at the time Idle was activated. ALE and PSEN hold at logic high levels.

There are two ways to terminate the Idle. Activation of any enabled interrupt will cause PCON.0 to be cleared by hardware, terminating the Idle mode. The interrupt will be serviced, and following RETI the next instruction to be executed will be the one following the instruction that put the device into idle.

The flag bits GF0 and GF1 can be used to give and indication if an interrupt occured during normal operation or during an Idle. For example, an instruction that activates Idle can also set one or both flag bits. When Idle is terminated by an interrupt, the interrupt service routine can examine the flag bits.

The over way of terminating the Idle mode is with a hardware reset. Since the clock oscillator is still running, the hardware reset needs to be held active for only two machine cycles (24 oscillator periods) to complete the reset.

#### 6.6 Power-Down Mode

To save maximum power, a power-down mode can be invoked by software (Refer to Table 6., PCON register).

In power-down mode, the oscillator is stopped and the instruction that invoked power-down mode is the last instruction executed. The internal RAM and SFRs retain their value until the power-down mode is terminated.  $V_{CC}$  can be lowered to save further power. Either a hardware reset or an external interrupt can cause an exit from power-down. To properly terminate power-down, the reset or external interrupt should not be executed before  $V_{CC}$  is restored to its normal operating level and must be held active long enough for the oscillator to restart and stabilize.

Only external interrupts  $\overline{\text{INT0}}$  and  $\overline{\text{INT1}}$  are useful to exit from power-down. For that, interrupt must be enabled and configured as level or edge sensitive interrupt input.

Holding the pin low restarts the oscillator but bringing the pin high completes the exit as detailed in Figure 8. When both interrupts are enabled, the oscillator restarts as soon as one of the two inputs is held low and power down exit will be completed when the first input will be released. In this case the higher priority interrupt service routine is executed.

Once the interrupt is serviced, the next instruction to be executed after RETI will be the one following the instruction that put TS80C31X2 into power-down mode.

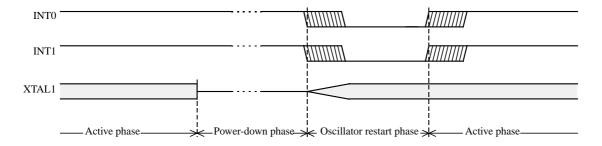


Figure 8. Power-Down Exit Waveform

Exit from power-down by reset redefines all the SFRs, exit from power-down by external interrupt does no affect the SFRs.

Exit from power-down by either reset or external interrupt does not affect the internal RAM content.

NOTE: If idle mode is activated with power-down mode (IDL and PD bits set), the exit sequence is unchanged, when execution is vectored to interrupt, PD and IDL bits are cleared and idle mode is not entered.



## 6.8 Power-Off Flag

The power-off flag allows the user to distinguish between a "cold start" reset and a "warm start" reset.

A cold start reset is the one induced by  $V_{CC}$  switch-on. A warm start reset occurs while  $V_{CC}$  is still applied to the device and could be generated for example by an exit from power-down.

The power-off flag (POF) is located in PCON register (See Table 13.). POF is set by hardware when  $V_{CC}$  rises from 0 to its nominal voltage. The POF can be set or cleared by software allowing the user to determine the type of reset.

The POF value is only relevant with a Vcc range from 4.5V to 5.5V. For lower Vcc value, reading POF bit will return indeterminate value.

### Table 13. PCON Register

#### PCON - Power Control Register (87h)

7	6	5	4	3	2	1	0
SMOD1	SMOD0	-	POF	GF1	GF0	PD	IDL

Bit Number	Bit Mnemonic	Description
7	SMOD1	Serial port Mode bit 1 Set to select double baud rate in mode 1, 2 or 3.
6	SMOD0	Serial port Mode bit 0 Clear to select SM0 bit in SCON register. Set to to select FE bit in SCON register.
5	-	Reserved  The value read from this bit is indeterminate. Do not set this bit.
4	POF	Power-Off Flag Clear to recognize next reset type. Set by hardware when $V_{CC}$ rises from 0 to its nominal voltage. Can also be set by software.
3	GF1	General purpose Flag Cleared by user for general purpose usage. Set by user for general purpose usage.
2	GF0	General purpose Flag Cleared by user for general purpose usage. Set by user for general purpose usage.
1	PD	Power-Down mode bit Cleared by hardware when reset occurs. Set to enter power-down mode.
0	IDL	Idle mode bit Clear by hardware when interrupt or reset occurs. Set to enter idle mode.

Reset Value = 00X1 0000b

Not bit addressable



### 7. Electrical Characteristics

# 7.1 Absolute Maximum Ratings (1)

Ambiant Temperature Under Bias:

C = commercial0°C to 70°C I = industrial-40°C to 85°C Storage Temperature  $-65^{\circ}$ C to  $+ 150^{\circ}$ C Voltage on V<sub>CC</sub> to V<sub>SS</sub> -0.5 V to + 7 VVoltage on V<sub>PP</sub> to V<sub>SS</sub> -0.5 V to + 13 VVoltage on Any Pin to VSS -0.5 V to  $V_{CC} + 0.5 \text{ V}$ 

 $1 W^{(2)}$ Power Dissipation

#### NOTES

### 7.2 Power consumption measurement

Since the introduction of the first C51 devices, every manufacturer made operating Icc measurements under reset, which made sense for the designs were the CPU was running under reset. In Atmel Wireless & Microcontrollers new devices, the CPU is no more active during reset, so the power consumption is very low but is not really representative of what will happen in the customer system. That's why, while keeping measurements under Reset, Atmel Wireless & Microcontrollers presents a new way to measure the operating Icc:

Using an internal test ROM, the following code is executed:

Label: SJMP Label (80 FE)

Ports 1, 2, 3 are disconnected, Port 0 is tied to FFh, EA = Vcc, RST = Vss, XTAL2 is not connected and XTAL1 is driven by the clock.

This is much more representative of the real operating Icc.

<sup>1.</sup> Stresses at or above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

This value is based on the maximum allowable die temperature and the thermal resistance of the package.



# 7.3 DC Parameters for Standard Voltage

Ta = 0°C to +70°C;  $V_{SS}$  = 0 V;  $V_{CC}$  = 5 V ± 10%; F = 0 to 40 MHz. Ta = -40°C to +85°C;  $V_{SS}$  = 0 V;  $V_{CC}$  = 5 V ± 10%; F = 0 to 40 MHz.

Table 14. DC Parameters in Standard Voltage

Symbol	Parameter	Min	Тур	Max	Unit	Test Conditions
V <sub>IL</sub>	Input Low Voltage	-0.5		0.2 V <sub>CC</sub> - 0.1	V	
V <sub>IH</sub>	Input High Voltage except XTAL1, RST	0.2 V <sub>CC</sub> + 0.9		V <sub>CC</sub> + 0.5	V	
V <sub>IH1</sub>	Input High Voltage, XTAL1, RST	0.7 V <sub>CC</sub>		V <sub>CC</sub> + 0.5	V	
V <sub>OL</sub>	Output Low Voltage, ports 1, 2, 3 <sup>(6)</sup>			0.3 0.45 1.0	V V V	$I_{OL} = 100 \ \mu A^{(4)}$ $I_{OL} = 1.6 \ mA^{(4)}$ $I_{OL} = 3.5 \ mA^{(4)}$
V <sub>OL1</sub>	Output Low Voltage, port 0 (6)			0.3 0.45 1.0	V V V	$I_{OL} = 200 \ \mu A^{(4)}$ $I_{OL} = 3.2 \ mA^{(4)}$ $I_{OL} = 7.0 \ mA^{(4)}$
V <sub>OL2</sub>	Output Low Voltage, ALE, PSEN			0.3 0.45 1.0	V V V	$I_{OL} = 100 \ \mu A^{(4)}$ $I_{OL} = 1.6 \ mA^{(4)}$ $I_{OL} = 3.5 \ mA^{(4)}$
V <sub>OH</sub>	Output High Voltage, ports 1, 2, 3	V <sub>CC</sub> - 0.3 V <sub>CC</sub> - 0.7 V <sub>CC</sub> - 1.5			V V V	$\begin{split} I_{OH} &= -10 \ \mu A \\ I_{OH} &= -30 \ \mu A \\ I_{OH} &= -60 \ \mu A \\ V_{CC} &= 5 \ V \pm 10\% \end{split}$
V <sub>OH1</sub>	Output High Voltage, port 0	V <sub>CC</sub> - 0.3 V <sub>CC</sub> - 0.7 V <sub>CC</sub> - 1.5			V V V	$I_{OH} = -200 \ \mu A$ $I_{OH} = -3.2 \ mA$ $I_{OH} = -7.0 \ mA$ $V_{CC} = 5 \ V \pm 10\%$
V <sub>OH2</sub>	Output High Voltage, ALE, PSEN	V <sub>CC</sub> - 0.3 V <sub>CC</sub> - 0.7 V <sub>CC</sub> - 1.5			V V V	$I_{OH} = -100 \ \mu A$ $I_{OH} = -1.6 \ mA$ $I_{OH} = -3.5 \ mA$ $V_{CC} = 5 \ V \pm 10\%$
R <sub>RST</sub>	RST Pulldown Resistor	50	90 (5)	200	kΩ	
I <sub>IL</sub>	Logical 0 Input Current ports 1, 2 and 3			-50	μА	Vin = 0.45 V
$I_{LI}$	Input Leakage Current			±10	μΑ	0.45 V < Vin < V <sub>CC</sub>
I <sub>TL</sub>	Logical 1 to 0 Transition Current, ports 1, 2, 3			-650	μΑ	Vin = 2.0 V
C <sub>IO</sub>	Capacitance of I/O Buffer			10	pF	Fc = 1 MHz TA = 25°C
$I_{\mathrm{PD}}$	Power Down Current		20 (5)	50	μА	$2.0 \text{ V} < \text{V}_{\text{CC}} < 5.5 \text{ V}^{(3)}$
I <sub>CC</sub> under RESET	Power Supply Current Maximum values, X1 mode: (7)			1 + 0.4 Freq (MHz) @12MHz 5.8 @16MHz 7.4	mA	$V_{CC} = 5.5 V^{(1)}$



Symbol	Parameter	Min	Тур	Max	Unit	Test Conditions
I <sub>CC</sub> idle	Power Supply Current Maximum values, X1 mode: (7)			0.15 Freq (MHz) + 0.2 @12MHz 2 @16MHz 2.6	mA	$V_{CC} = 3.3 V^{(2)}$

#### **NOTES**

- 1.  $I_{CC}$  under reset is measured with all output pins disconnected; XTAL1 driven with  $T_{CLCH}$ ,  $T_{CHCL} = 5$  ns (see Figure 13.),  $V_{IL} = V_{SS} + 0.5$  V,  $V_{IH} = V_{CC} 0.5$ V; XTAL2 N.C.;  $\overline{EA} = RST = Port\ 0 = V_{CC}$ .  $I_{CC}$  would be slightly higher if a crystal oscillator used..
- 2. Idle  $I_{CC}$  is measured with all output pins disconnected; XTAL1 driven with  $T_{CLCH}$ ,  $T_{CHCL} = 5$  ns,  $V_{IL} = V_{SS} + 0.5$  V,  $V_{IH} = V_{CC} 0.5$  V; XTAL2 N.C; Port  $0 = V_{CC}$ ;  $\overline{EA} = RST = V_{SS}$  (see Figure 11.).
- 3. Power Down  $I_{CC}$  is measured with all output pins disconnected;  $\overline{EA} = V_{SS}$ , PORT  $0 = V_{CC}$ ; XTAL2 NC.; RST =  $V_{SS}$  (see Figure 12.).
- 4. Capacitance loading on Ports 0 and 2 may cause spurious noise pulses to be superimposed on the  $V_{OL}s$  of ALE and Ports 1 and 3. The noise is due to external bus capacitance discharging into the Port 0 and Port 2 pins when these pins make 1 to 0 transitions during bus operation. In the worst cases (capacitive loading 100pF), the noise pulse on the ALE line may exceed 0.45V with maxi  $V_{OL}$  peak 0.6V. A Schmitt Trigger use is not necessary.
- 5. Typicals are based on a limited number of samples and are not guaranteed. The values listed are at room temperature and 5V.
  - Under steady state (non-transient) conditions,  $I_{OL}$  must be externally limited as follows:

Maximum I<sub>OL</sub> per port pin: 10 mA

Maximum I<sub>OL</sub> per 8-bit port:

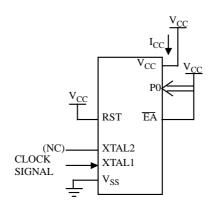
Port 0: 26 mA

Ports 1, 2 and 3: 15 mA

Maximum total  $I_{OL}$  for all output pins: 71 mA

 $If I_{OL}\ exceeds\ the\ test\ condition,\ V_{OL}\ may\ exceed\ the\ related\ specification.\ Pins\ are\ not\ guaranteed\ to\ sink\ current\ greater\ than\ the\ listed\ test\ conditions.$ 

- 7. For other values, please contact your sales office.
- 8. Operating  $I_{CC}$  is measured with all output pins disconnected; XTAL1 driven with  $T_{CLCH}$ ,  $T_{CHCL} = 5$  ns (see Figure 13.),  $V_{IL} = V_{SS} + 0.5$  V,  $V_{IH} = V_{CC} 0.5$ V; XTAL2 N.C.;  $\overline{EA} = Port\ 0 = V_{CC}$ ; RST =  $V_{SS}$ . The internal ROM runs the code 80 FE (label: SJMP label).  $I_{CC}$  would be slightly higher if a crystal oscillator is used. Measurements are made with OTP products when possible, which is the worst case.



All other pins are disconnected.

Figure 9. I<sub>CC</sub> Test Condition, under reset



#### 7.5 AC Parameters

#### 7.5.1 Explanation of the AC Symbols

Each timing symbol has 5 characters. The first character is always a "T" (stands for time). The other characters, depending on their positions, stand for the name of a signal or the logical status of that signal. The following is a list of all the characters and what they stand for.

Example: T<sub>AVLL</sub> = Time for Address Valid to ALE Low.

 $T_{LLPL}$  = Time for ALE Low to  $\overline{PSEN}$  Low.

TA = 0 to +70°C (commercial temperature range);  $V_{SS} = 0$  V;  $V_{CC} = 5$  V  $\pm$  10%; -M and -V ranges.

TA = -40°C to +85°C (industrial temperature range);  $V_{SS} = 0$  V;  $V_{CC} = 5$  V  $\pm$  10%; -M and -V ranges.

TA = 0 to +70°C (commercial temperature range);  $V_{SS} = 0$  V; 2.7 V <  $V_{CC} < 5.5$  V; -L range.

TA = -40°C to +85°C (industrial temperature range);  $V_{SS} = 0~V; 2.7~V < V_{CC} < 5.5~V;$  -L range.

Table 16. gives the maximum applicable load capacitance for Port 0, Port 1, 2 and 3, and ALE and  $\overline{\text{PSEN}}$  signals. Timings will be guaranteed if these capacitances are respected. Higher capacitance values can be used, but timings will then be degraded.

 Port 0
 100
 50
 100

 Port 1, 2, 3
 80
 50
 80

 ALE / PSEN
 100
 30
 100

Table 16. Load Capacitance versus speed range, in pF

Table 18., Table 21. and Table 24. give the description of each AC symbols.

Table 19., Table 22. and Table 25. give for each range the AC parameter.

Table 20., Table 23. and Table 26. give the frequency derating formula of the AC parameter. To calculate each AC symbols, take the x value corresponding to the speed grade you need (-M, -V or -L) and replace this value in the formula. Values of the frequency must be limited to the corresponding speed grade:

Table 17. Max frequency for derating formula regarding the speed grade

	-M X1 mode	-M X2 mode	-V X1 mode	-V X2 mode	-L X1 mode	-L X2 mode
Freq (MHz)	40	20	40	30	30	20
T (ns)	25	50	25	33.3	33.3	50

Example:

 $T_{LLIV}$  in X2 mode for a -V part at 20 MHz (T =  $1/20^{E6}$  = 50 ns):

x= 25 (Table 20.)

T=50ns

 $T_{LLIV} = 2T - x = 2 \times 50 - 25 = 75 \text{ns}$ 



Table 22. AC Parameters for a Fix Clock

Speed	-M 40 MHz		X2 r 30 N	V node MHz z equiv.	standar	V rd mode MHz	X2 r 20 N	L mode MHz z equiv.	standaı	L rd mode MHz	Units
Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
T <sub>RLRH</sub>	130		85		135		125		175		ns
$T_{WLWH}$	130		85		135		125		175		ns
$T_{RLDV}$		100		60		102		95		137	ns
$T_{RHDX}$	0		0		0		0		0		ns
$T_{RHDZ}$		30		18		35		25		42	ns
$T_{LLDV}$		160		98		165		155		222	ns
T <sub>AVDV</sub>		165		100		175		160		235	ns
$T_{LLWL}$	50	100	30	70	55	95	45	105	70	130	ns
T <sub>AVWL</sub>	75		47		80		70		103		ns
T <sub>QVWX</sub>	10		7		15		5		13		ns
T <sub>QVWH</sub>	160		107		165		155		213		ns
$T_{WHQX}$	15		9		17		10		18		ns
$T_{RLAZ}$		0		0		0		0		0	ns
$T_{WHLH}$	10	40	7	27	15	35	5	45	13	53	ns



Table 23. AC Parameters for a Variable Clock: derating formula

Symbol	Туре	Standard Clock	X2 Clock	-M	-V	-L	Units
$T_{RLRH}$	Min	6 T - x	3 T - x	20	15	25	ns
$T_{WLWH}$	Min	6 T - x	3 T - x	20	15	25	ns
$T_{RLDV}$	Max	5 T - x	2.5 T - x	25	23	30	ns
$T_{RHDX}$	Min	x	х	0	0	0	ns
$T_{RHDZ}$	Max	2 T - x	T - x	20	15	25	ns
$T_{LLDV}$	Max	8 T - x	4T -x	40	35	45	ns
T <sub>AVDV</sub>	Max	9 T - x	4.5 T - x	60	50	65	ns
$T_{LLWL}$	Min	3 T - x	1.5 T - x	25	20	30	ns
$T_{LLWL}$	Max	3 T + x	1.5 T + x	25	20	30	ns
$T_{AVWL}$	Min	4 T - x	2 T - x	25	20	30	ns
$T_{QVWX}$	Min	T - x	0.5 T - x	15	10	20	ns
$T_{QVWH}$	Min	7 T - x	3.5 T - x	15	10	20	ns
$T_{WHQX}$	Min	T - x	0.5 T - x	10	8	15	ns
$T_{RLAZ}$	Max	x	х	0	0	0	ns
$T_{WHLH}$	Min	T - x	0.5 T - x	15	10	20	ns
$T_{WHLH}$	Max	T + x	0.5 T + x	15	10	20	ns

# 7.5.5 External Data Memory Write Cycle

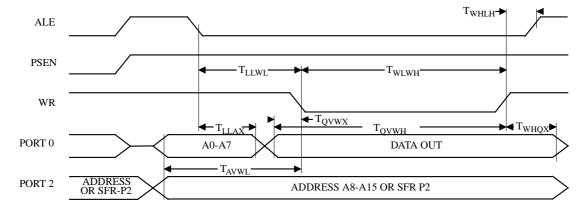


Figure 15. External Data Memory Write Cycle



## 7.5.6 External Data Memory Read Cycle

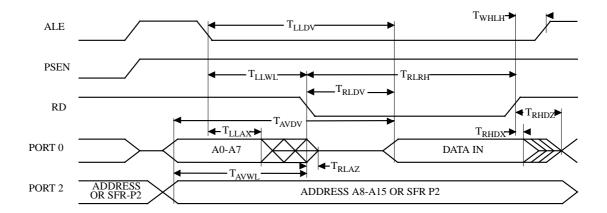


Figure 16. External Data Memory Read Cycle

## 7.5.7 Serial Port Timing - Shift Register Mode

**Table 24. Symbol Description** 

Symbol	Parameter
T <sub>XLXL</sub>	Serial port clock cycle time
T <sub>QVHX</sub>	Output data set-up to clock rising edge
T <sub>XHQX</sub>	Output data hold after clock rising edge
T <sub>XHDX</sub>	Input data hold after clock rising edge
T <sub>XHDV</sub>	Clock rising edge to input data valid

Table 25. AC Parameters for a Fix Clock

Speed	-M 40 MHz		X2 n 30 N	V node MHz z equiv.		V rd mode MHz	X2 r 20 N	L node MHz z equiv.	standar	L d mode MHz	Units
Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
T <sub>XLXL</sub>	300		200		300		300		400		ns
T <sub>QVHX</sub>	200		117		200		200		283		ns
T <sub>XHQX</sub>	30		13		30		30		47		ns
T <sub>XHDX</sub>	0		0		0		0		0		ns
T <sub>XHDV</sub>		117		34		117		117		200	ns



Table 26. AC Parameters for a Variable Clock: derating formula

Symbol	Туре	Standard Clock	X2 Clock	-M	-V	-L	Units
$T_{XLXL}$	Min	12 T	6 T				ns
T <sub>QVHX</sub>	Min	10 T - x	5 T - x	50	50	50	ns
T <sub>XHQX</sub>	Min	2 T - x	T - x	20	20	20	ns
T <sub>XHDX</sub>	Min	Х	х	0	0	0	ns
T <sub>XHDV</sub>	Max	10 T - x	5 T- x	133	133	133	ns

# 7.5.8 Shift Register Timing Waveforms

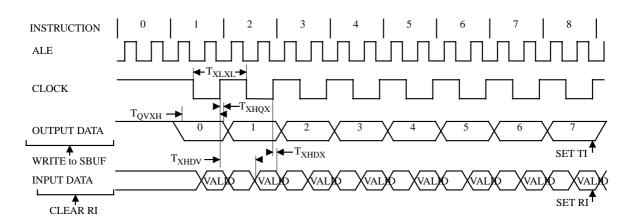


Figure 17. Shift Register Timing Waveforms



# 8. Ordering Information

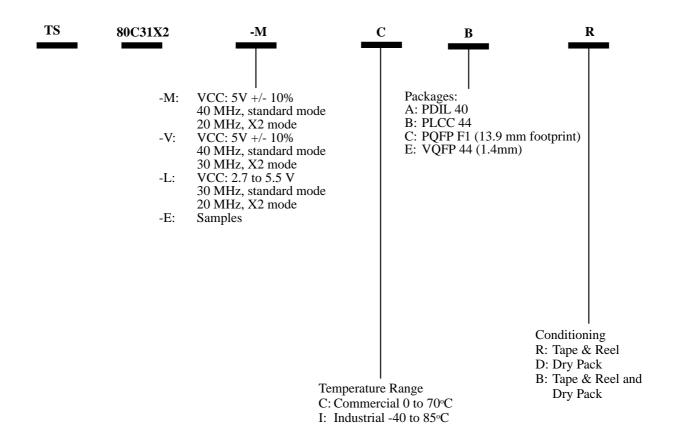


Table 28. Maximum Clock Frequency

Code	-M	-V	-L	Unit
Standard Mode, oscillator frequency	40	40	30	MHz
Standard Mode, internal frequency	40	40	30	
X2 Mode, oscillator frequency	20	30	20	MHz
X2 Mode, internal equivalent frequency	40	<b>60</b>	<b>40</b>	

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